# **Power MOSFET**

# 30 V, 171 A, Single N-Channel, SO-8 FL

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Includes Schottky Diode
- Optimized Gate Charge to Minimize Switching Losses
- Dual Sided Cooling Capability
- These are Pb-Free Device

## **Applications**

- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

	Symbol	Value	Unit		
Parameter			,		
Drain-to-Source Voltage			V <sub>DSS</sub>	30	V
	Gate-to-Source Voltage			±20	V
Continuous Drain Current R <sub>0JA</sub>		$T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	Ι <sub>D</sub>	29 21	Α
(Note 1)		, ,			
Power Dissipation $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.74	W
Continuous Drain	1	T <sub>A</sub> = 25°C	Ι <sub>D</sub>	47	Α
Current R <sub>θJA</sub> ≤ 10 sec		T <sub>A</sub> = 85°C		34	
Power Dissipation $R_{\theta JA,} t \leq 10 \text{ sec}$	Steady	T <sub>A</sub> = 25°C	P <sub>D</sub>	7.3	W
Continuous Drain	State	T <sub>A</sub> = 25°C	I <sub>D</sub>	17	Α
Current R <sub>θJA</sub> (Note 2)		T <sub>A</sub> = 85°C		12	
Power Dissipation $R_{\theta JA}$ (Note 2)		T <sub>A</sub> = 25°C	P <sub>D</sub>	0.95	W
Continuous Drain	1	T <sub>C</sub> = 25°C	Ι <sub>D</sub>	171	Α
Current R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 85°C		123	
Power Dissipation $R_{\theta JC}$ (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	96.2	W
Pulsed Drain Current	t <sub>p</sub> =10μs	T <sub>A</sub> = 25°C	I <sub>DM</sub>	288	Α
Current limited by pa	Current limited by package $T_A = 25^{\circ}C$			100	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	-40 to +150	°C
Source Current (Body Diode)			I <sub>S</sub>	120	Α
Drain to Source dV/dt			dV/dt	6	V/ns
Single Pulse Drain-to-Source Avalanche Energy ( $V_{DD}$ = 50 V, $V_{GS}$ = 10 V, $I_L$ = 50 $A_{pk}$ , $L$ = 0.3 mH, $R_G$ = 25 $\Omega$ )			EAS	375	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

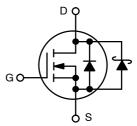


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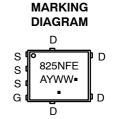
### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX	
30 V	2.0 mΩ @ 10 V	171 A	
30 V	3.0 mΩ @ 4.5 V	140 A	

#### **N-CHANNEL MOSFET**







A = Assembly Location

Y = Year
WW = Work Week
= Pb-Free Package

(Note: Microdot may be in either location)

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTMFS4825NFET1G	SO-8FL (Pb-Free)	1500 / Tape & Reel
NTMFS4825NFET3G	SO-8FL (Pb-Free)	5000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

<sup>\*</sup>For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	1.3	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	45.7	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	132.1	°C/W
Junction-to-Ambient - t ≤ 10 sec	$R_{ heta JA}$	17.2	
Junction-to-Top	$R_{ heta JT}$	7.0	

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

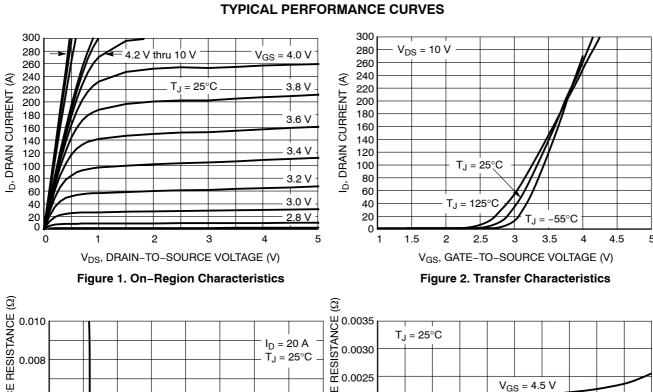
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					•		
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1.0 mA		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				28.5		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V	T <sub>J</sub> = 25 °C		60	500	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 1.0 mA	1.5	2.0	2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 22 A		1.3	2.0	1
			I <sub>D</sub> = 20 A		1.3		
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 20 A		2.0	3.0	mΩ
			I <sub>D</sub> = 18 A		2.0		1
Forward Transconductance	9FS	V <sub>DS</sub> = 15 V, I <sub>D</sub>	= 15 A		90		S
CHARGES AND CAPACITANCES					•		
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 15 V			5660		pF
Output Capacitance	C <sub>OSS</sub>				1150		
Reverse Transfer Capacitance	C <sub>RSS</sub>				495		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 23 A			40.2		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				6.4		
Gate-to-Source Charge	$Q_{GS}$				15.3		
Gate-to-Drain Charge	$Q_{GD}$				13.4		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V, I <sub>D</sub> = 23 A			83.6		nC
SWITCHING CHARACTERISTICS (Note 4)				•	_	•	•
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 15 V, $I_{D}$ = 15 A, $R_{G}$ = 3.0 $\Omega$			26		
Rise Time	t <sub>r</sub>				24		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				36		ns
Fall Time	t <sub>f</sub>				13		1

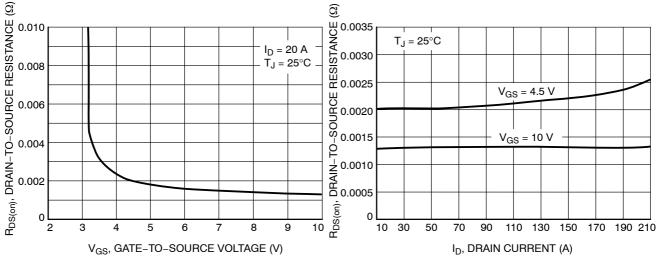
- Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
   Switching characteristics are independent of operating junction temperatures.

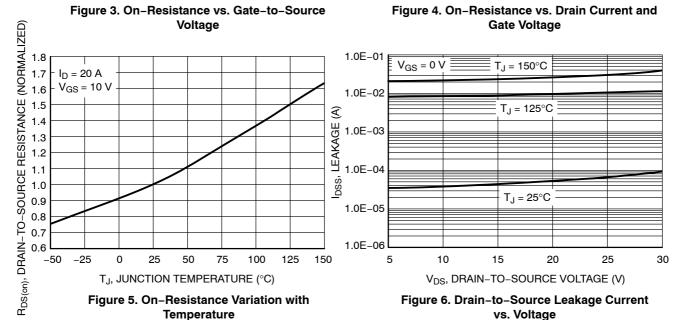
## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 4)						
Turn-On Delay Time	t <sub>d(ON)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V,			15.7		
Rise Time	t <sub>r</sub>				21.2		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 15 A, R_G$	$_{\rm i}$ = 3.0 $\Omega$		44.6		ns
Fall Time	t <sub>f</sub>	1			14.5		1
DRAIN-SOURCE DIODE CHARACTI	ERISTICS						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.35	0.70	V
			T <sub>J</sub> = 125°C		0.26		
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A}/\mu s,$ $I_{S} = 23 \text{ A}$			39.1		ns
Charge Time	t <sub>a</sub>				20.1		
Discharge Time	t <sub>b</sub>				19		
Reverse Recovery Charge	Q <sub>RR</sub>				34		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>	T <sub>A</sub> = 25°C			0.66		nΗ
Drain Inductance	L <sub>D</sub>				0.20		
Gate Inductance	L <sub>G</sub>				1.5		
Gate Resistance	$R_{G}$				0.7	2.0	Ω

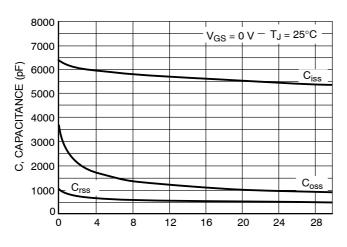
Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.







#### TYPICAL PERFORMANCE CURVES



V<sub>DS</sub>, DRAIN-TO-SOURCE VOLTAGE (V)

Figure 7. Capacitance Variation

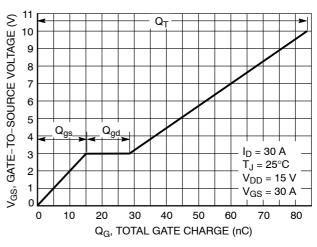


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

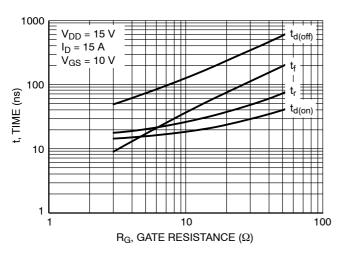


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

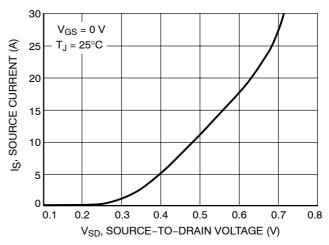


Figure 10. Diode Forward Voltage vs. Current

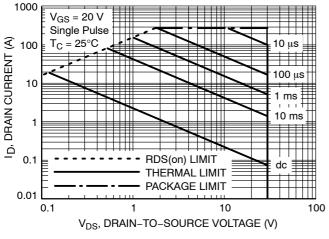


Figure 11. Maximum Rated Forward Biased Safe Operating Area

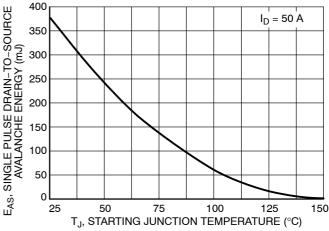
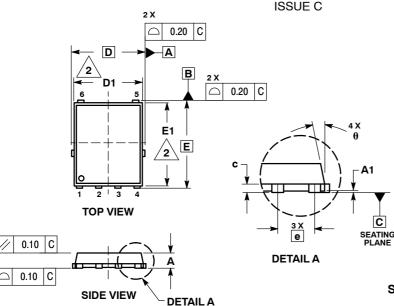


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

#### PACKAGE DIMENSIONS

## DFN6 5x6, 1.27P (SO8 FL) CASE 488AA-01



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**BOTTOM VIEW** 

STYLE 1:

3

PIN 1. SOURCE 2. SOURCE

SOURCE

GATE DRAIN

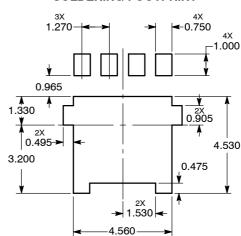
6. DRAIN

#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETER. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D		5.15 BSC	;		
D1	4.50	4.90	5.10		
D2	3.50		4.22		
E	6.15 BSC				
E1	5.50	5.80	6.10		
E2	3.45		4.30		
е	1.27 BSC				
G	0.51	0.61	0.71		
K	0.51				
L	0.51	0.61	0.71		
L1	0.05	0.17	0.20		
М	3.00	3.40	3.80		
θ	0 °		12 °		

#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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